NOTES:

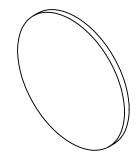
- 1. Substrate
- 2. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES
- 3. COATING (APPLY ACROSS COATING APERTURE)
 - \$1: Ravg ≥ 95% @ 400 690nm @ 45° AOI Tavg ≥ 90% @ 750 - 1200nm @ 45° AOI
 - S2: AR Coating: Ravg < 1.0% @ 700 1150nm@ 45° AOI

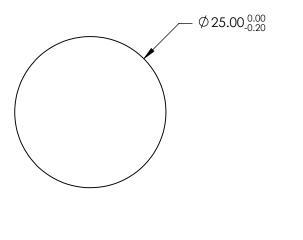


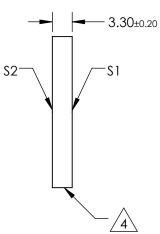
FINE GRIND SURFACE

- POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. Rohs Compliant









SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

SHAPE	S1 PLANO	S2 PLANO			Edmund Optics®	'
SURFACE FLATNESS	4 - 6λ	4 - 6λ	THIRD ANGLE	TITLE	Ø25mm, 45° AOI, COLD MIRROR	
SURFACE QUALITY	80-50	80-50	PROJECTION PROJECTION		, , , , , , , , , , , , , , , , , , , ,	
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	64447 SHEI	